



# **MURANG'A UNIVERSITY OF TECHNOLOGY**

## **SCHOOL OF PURE AND APPLIED SCIENCES**

DEPARTMENT OF MATHEMATICS AND ACTUARIAL SCIENCE

UNIVERSITY ORDINARY EXAMINATION

2023/2024 ACADEMIC YEAR

**SECOND YEAR SECOND SEMESTER EXAMINATION FOR BACHELOR  
OF SCIENCE IN ELECTRICAL AND ELECTRONICS ENGINEERING**

**EES 210: PHYSICAL ELECTRONICS II**

**DURATION: 2 HOURS**

### **INSTRUCTIONS TO CANDIDATES:**

1. Answer Question one and any other two questions.
2. Mobile phones are not allowed in the examination room.
3. You are not allowed to write on this examination question paper.

## SECTION A: ANSWER ALL QUESTIONS IN THIS SECTION

### QUESTION ONE (30 MARKS)

- a) Briefly describe the following terms as applied in quantitative analysis of pn junction diode (2½marks)
- Long pn junction
  - Low injection current
  - Recombination current
  - Ambipolar transport
- b) State and briefly explain two types of optical losses as a result of spectral mismatch as applied to solar cells. (2marks)
- c) The Nobel physics prize of 1905 was won by Einstein for explaining the photoelectric effect.
- Briefly explain the main differences and similarities between photoelectric effect and photovoltaic effect. (4marks)
  - Explain briefly how if at all photoelectric effect could be used to generate useful energy (2marks)
- d) Distinguish between conversion efficiency and external quantum efficiency (EQE) as applied to solar cells. With aid of a suitable diagram, briefly explain how the EQE of light of varied wavelength incident on its surface (3½marks)
- e) Define the term “pinch off” as applied to JFETs and explain its significance in electronic circuit design (2marks)
- f) Briefly explain with aid of a well labelled diagram and associate equations the distribution and steady state concentrations of minority carriers in a long pn junction under forward bias (3marks)
- g) The V-J characteristics of a pn junction diode are NOT bilateral. Briefly substantiate this fact. (3marks)
- h) State and briefly explain two ways of minimizing shading loss in solar cells (2marks)
- i) State four advantages of using a perovskite solar cell over the conventional solar cells (2marks)

- j) For the silicon pn junction at  $T=300\text{k}$  with doping concentration of  $N_a = 10^{18}\text{cm}^{-3}$  and  $N_d = 5 \times 10^{15}\text{cm}^{-3}$ . Assuming abrupt depletion layer approximation applies
- Calculate the fermi level position in the p and n regions of the junction  
(2marks)
  - Draw a well labelled equilibrium band diagram for the junction and determine the barrier potential from the diagram  
(2marks)

## SECTION TWO: ANSWER ANY TWO QUESTIONS

### QUESTION TWO (20 MARKS)

- a) A crystalline silicon solar cell generates a photocurrent of  $J_{ph}=25\text{mA/cm}^2$ . The wafer is doped with  $10^{17}\text{cm}^{-3}$  acceptor atoms and the emitter layer is formed with a uniform concentration of  $10^{19}\text{cm}^{-3}$  donor atoms. The minority carrier diffusion length in the p type region and n-type region is  $500 \times 10^{-6}\text{m}$  and  $10 \times 10^{-6}\text{m}$ , respectively. Further, the intrinsic carrier concentration in silicon at  $300\text{k}$  is  $1.5 \times 10^{10}\text{cm}^{-3}$ , the mobility of electrons in the p type region is  $M_n=1000\text{cm}^2/\text{v-s}$  and hole in the n type region is  $M_p=100\text{cm}^2/\text{v-s}$ . Assume that the solar cell behaves like an ideal diode, Calculate the under listed parameters of the solar cell.
- Built-in voltage  
(3marks)
  - Open circuit voltage  
(4marks)
  - Fill factor  
(4marks)
  - Conversion efficiency  
(3marks)
- b) With the aid of suitable diagram, briefly explain the effect of variation of light intensity and variation of cell temperature on the j-v characteristic of a solar cell.  
(6marks)

### QUESTION THREE (20 MARKS)

- a) A p + n junction of uniformly doped silicon in channel JFET at  $T = 300\text{k}$  has doping concentrations of  $N_a=10^{18}\text{cm}^{-3}$  and  $N_d=10^{16}\text{cm}^{-3}$ . Considering a channel thickness of  $a=0.75\text{mm}$ , channel width  $w=30\text{mm}$ , channel length =  $10\text{mm}$  and mobility of electrons  $U_n=1000\text{cm}^2/\text{v-s}$

- i. Calculate the internal pinch-off voltage and pinch-off voltage (5marks)
  - ii. Determine maximum current for the channel  $I_{D1}(\text{max})$  (4marks)
  - iii. Determine the maximum transconductance assuming the a channel depletion mode JFET is biased in the saturation region (3marks)
- b) Consider an n-channel GaAs MASFET at  $T=300\text{k}$  with gold schottky barrier contact and a barrier of  $\phi_{Bn} = 0.89\text{v}$  the channel doping concentration is  $N_d = 2 \times 10^{15} \text{cm}^{-3}$
- i. Design a channel thickness of the GaAs MESFET to achieve a threshold voltage of  $V_T = +0.25$ ,  $N_o = 4.7 \times 10^{17} \text{cm}^{-3}$ ,  $E_r = 13.1$  (6marks)
  - ii. From your design in (i) above, comment on the relationship between channel thickness “a” and threshold voltage “ $V_T$ ” (2marks)

#### QUESTION FOUR (20 MARKS)

- a) Consider a silicon pn junction at  $T=300\text{K}$  with doping parameters as  $N_a = N_d = 10^{16} \text{cm}^{-3}$ ,  $D_n = 25 \text{cm}^2/\text{s}$ ,  $D_p = 10 \text{cm}^2/\text{s}$  \_\_\_\_\_
- i. Determine the ideal reverse saturation current density of the junction (3marks)
  - ii. Calculate the electric field strength in the neutral region of the silicon diode to produce a given majority carrier drift current density with an applied forward bias voltage  $V_a = 0.65\text{V}$ . Assume  $M_n = 1359 \text{cm}^2/\text{v-s}$
- b) Derive the ideal-diode equation which gives a proper description of the j-v characteristics of a pn junction over a wide range of currents and voltages (6marks)
- c) With the help of a suitable diagram and appropriate equations, explain the difference of the j-v characteristics of a pn junction in the dark and under illumination (7marks)

Useful constraints;

Plank's constant,  $h = 6.626 \times 10^{-34} \text{m}^2\text{kg/s}$

Boltzman constant,  $k = 1.38 \times 10^{-23} \text{J/k}$

Charge of an electron  $e = 1.6 \times 10^{-19} \text{coloumb}$

\_\_\_ Intrinsic carrier concentration,  $n_i = 1.5 \times 10^{10} \text{cm}^{-3}$

Per \_\_\_ of free space, \_\_\_  $8.85 \times 10^{-12} \text{F/m}$